



# PMDPB42UN

20 V, dual N-channel Trench MOSFET

Rev. 1 — 16 May 2012

Product data sheet

## 1. Product profile

### 1.1 General description

Dual N-channel enhancement mode Field-Effect Transistor (FET) in a small and leadless ultra thin DFN2020-6 (SOT1118) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

### 1.2 Features and benefits

- Very fast switching
- Trench MOSFET technology
- Small and leadless ultra thin SMD plastic package: 2 x 2 x 0.65 mm
- Exposed drain pad for excellent thermal conduction

### 1.3 Applications

- Charging switch for portable devices
- DC-to-DC converters
- Small brushless DC motor drive
- Power management in battery-driven portables
- Hard disc and computing power management

### 1.4 Quick reference data

Table 1. Quick reference data

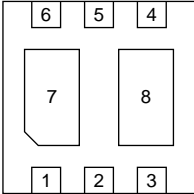
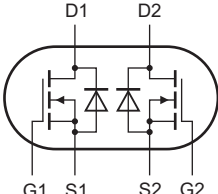
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Per transistor</b>						
$V_{DS}$	drain-source voltage	$T_j = 25\text{ °C}$	-	-	20	V
$V_{GS}$	gate-source voltage		-8	-	8	V
$I_D$	drain current	$V_{GS} = 4.5\text{ V}$ ; $T_{amb} = 25\text{ °C}$ ; $t \leq 5\text{ s}$	[1]	-	5.1	A
<b>Static characteristics (per transistor)</b>						
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 4.5\text{ V}$ ; $I_D = 3.9\text{ A}$ ; $T_j = 25\text{ °C}$	-	40	50	mΩ

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source TR1	 <p>Transparent top view</p> <p><b>SOT1118 (DFN2020-6)</b></p>	 <p>017aaa254</p>
2	G1	gate TR1		
3	D2	drain TR2		
4	S2	source TR2		
5	G2	gate TR2		
6	D1	drain TR1		
7	D1	drain TR1		
8	D2	drain TR2		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PMDPB42UN	DFN2020-6	plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals	SOT1118

4. Marking

Table 4. Marking codes

Type number	Marking code
PMDPB42UN	1L

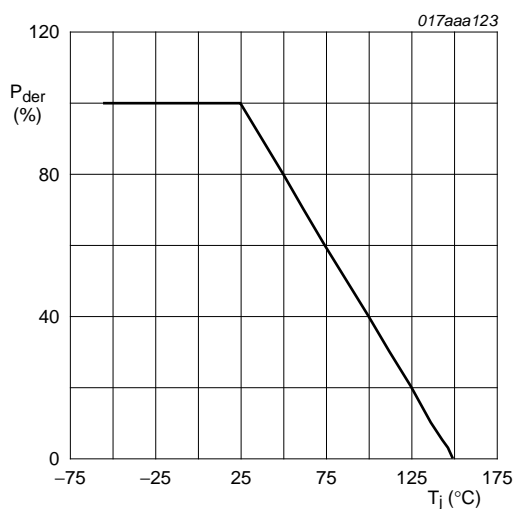
## 5. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

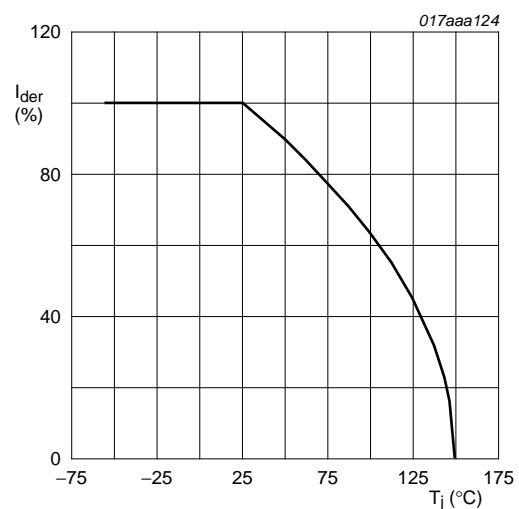
Symbol	Parameter	Conditions		Min	Max	Unit
Per transistor						
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C		-	20	V
V <sub>GS</sub>	gate-source voltage			-8	8	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 4.5 V; T <sub>amb</sub> = 25 °C; t ≤ 5 s	[1]	-	5.1	A
		V <sub>GS</sub> = 4.5 V; T <sub>amb</sub> = 25 °C	[1]	-	3.9	A
		V <sub>GS</sub> = 4.5 V; T <sub>amb</sub> = 100 °C	[1]	-	2.5	A
I <sub>DM</sub>	peak drain current	T <sub>amb</sub> = 25 °C; single pulse; t <sub>p</sub> ≤ 10 μs		-	15.6	A
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C	[2]	-	510	mW
			[1]	-	1165	mW
		T <sub>sp</sub> = 25 °C		-	8330	mW
Source-drain diode						
I <sub>S</sub>	source current	T <sub>amb</sub> = 25 °C	[1]	-	1.2	A
Per device						
T <sub>j</sub>	junction temperature			-55	150	°C
T <sub>amb</sub>	ambient temperature			-55	150	°C
T <sub>stg</sub>	storage temperature			-65	150	°C

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.  
 [2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.



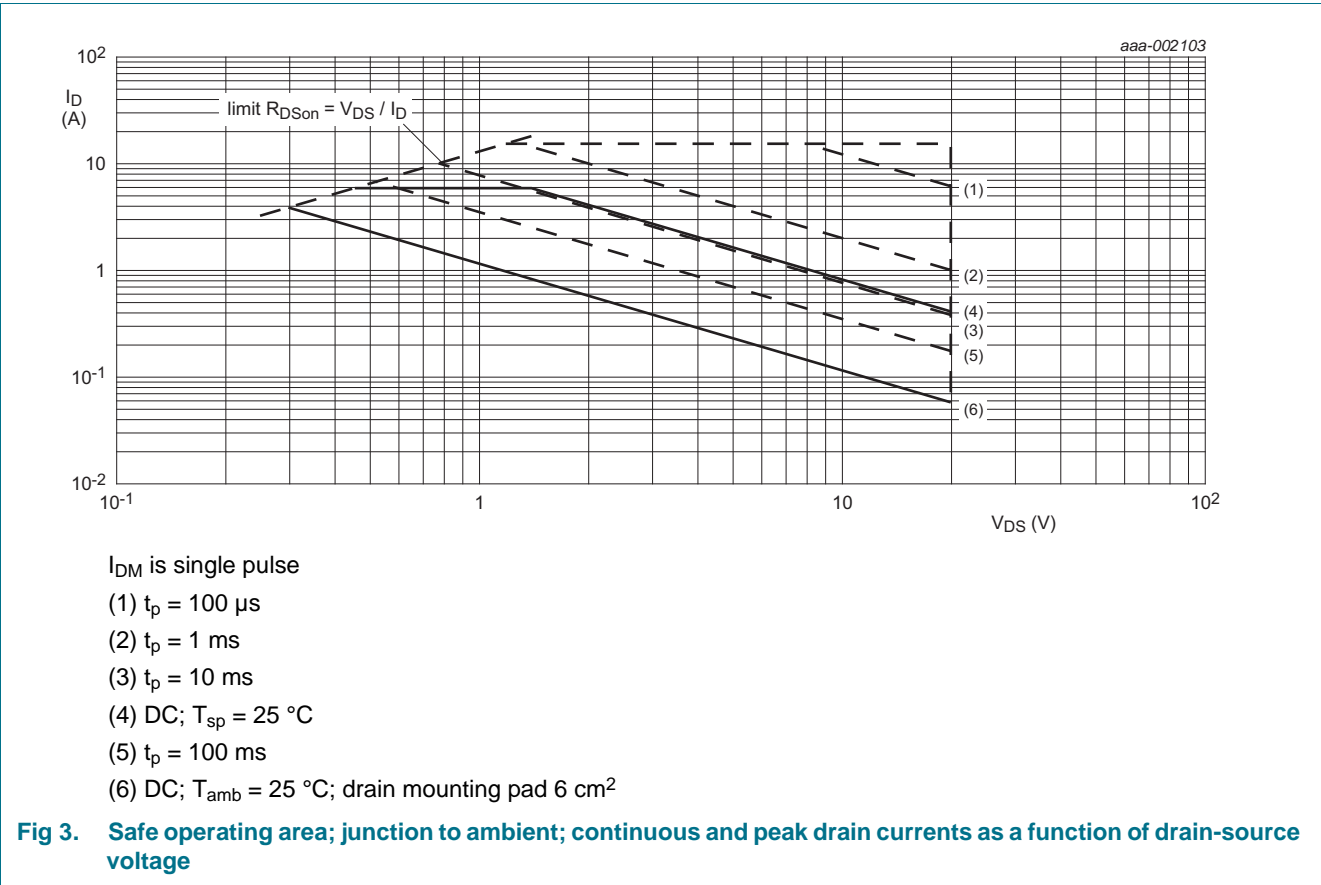
$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ\text{C})}} \times 100\%$$

**Fig 1. Normalized total power dissipation as a function of junction temperature**



$$I_{der} = \frac{I_D}{I_{D(25^\circ\text{C})}} \times 100\%$$

**Fig 2. Normalized continuous drain current as a function of junction temperature**



6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
Per transistor							
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air	<a href="#">[1]</a>	-	213	245	K/W
			<a href="#">[2]</a>	-	93	107	K/W
		in free air; t ≤ 5 s	<a href="#">[2]</a>	-	55	64	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		-	12	15	K/W	

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 6 cm².

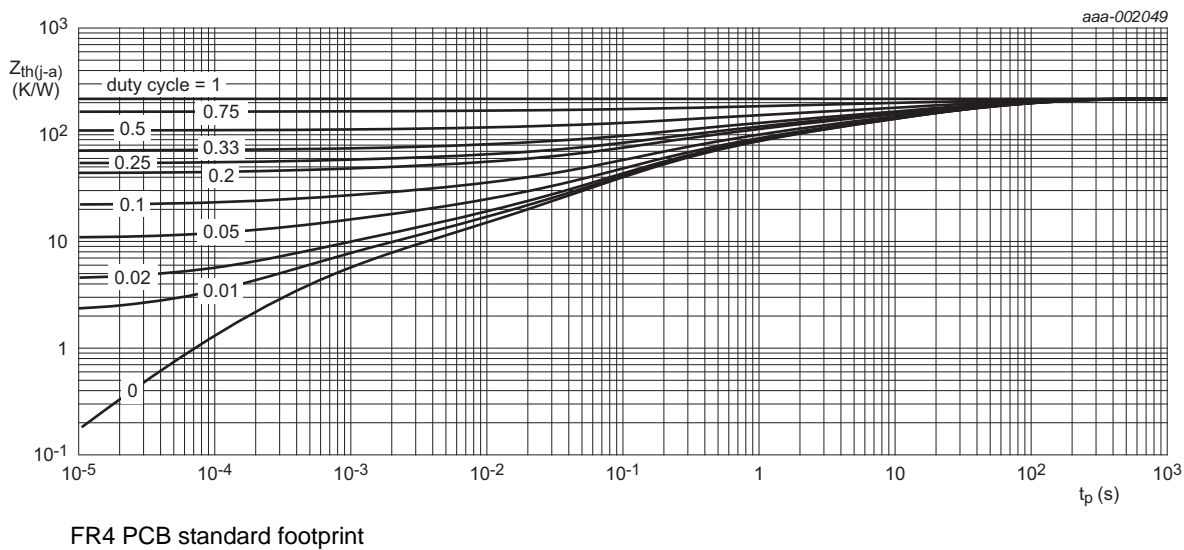


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

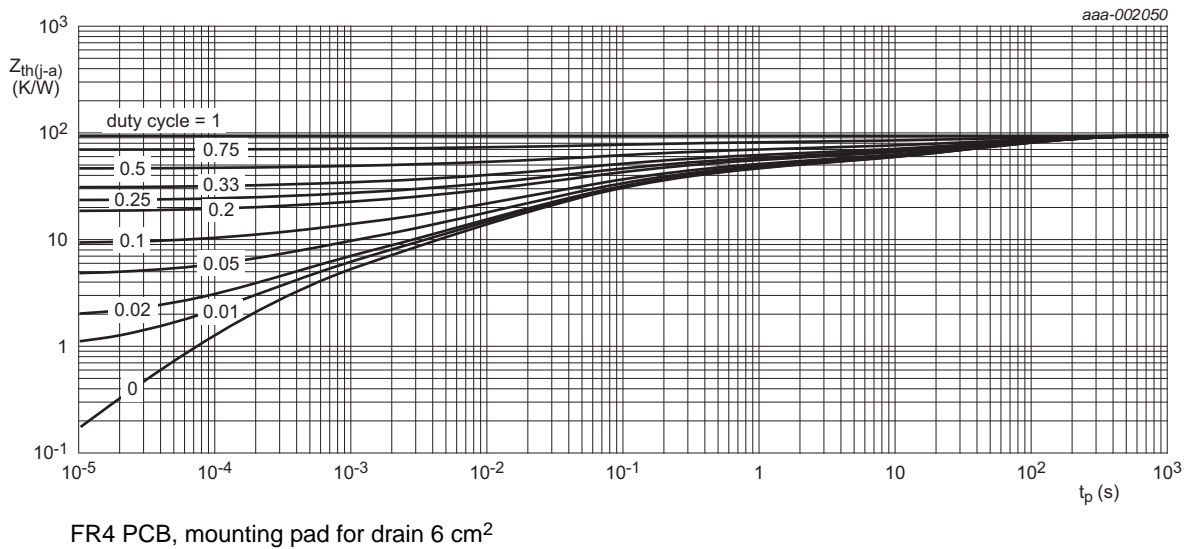
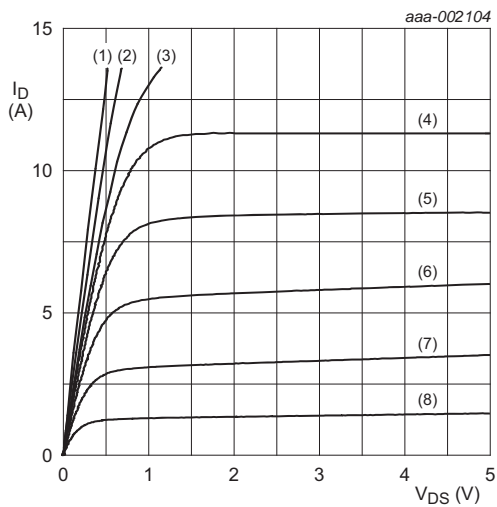


Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 7. Characteristics

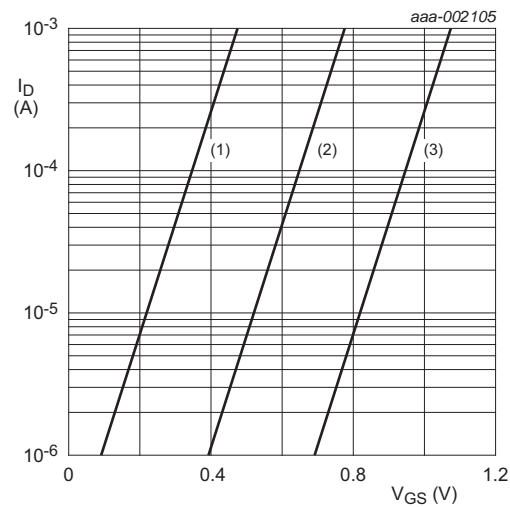
**Table 7. Characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics (per transistor)</b>						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250\ \mu A$ ; $V_{GS} = 0\ V$ ; $T_j = 25\ ^\circ C$	20	-	-	V
$V_{GSth}$	gate-source threshold voltage	$I_D = 250\ \mu A$ ; $V_{DS} = V_{GS}$ ; $T_j = 25\ ^\circ C$	0.4	0.7	1	V
$I_{DSS}$	drain leakage current	$V_{DS} = 20\ V$ ; $V_{GS} = 0\ V$ ; $T_j = 25\ ^\circ C$	-	-	1	$\mu A$
		$V_{DS} = 20\ V$ ; $V_{GS} = 0\ V$ ; $T_j = 150\ ^\circ C$	-	-	20	$\mu A$
$I_{GSS}$	gate leakage current	$V_{GS} = 8\ V$ ; $V_{DS} = 0\ V$ ; $T_j = 25\ ^\circ C$	-	-	100	nA
		$V_{GS} = -8\ V$ ; $V_{DS} = 0\ V$ ; $T_j = 25\ ^\circ C$	-	-	100	nA
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 4.5\ V$ ; $I_D = 3.9\ A$ ; $T_j = 25\ ^\circ C$	-	40	50	m $\Omega$
		$V_{GS} = 4.5\ V$ ; $I_D = 3.9\ A$ ; $T_j = 150\ ^\circ C$	-	61	76	m $\Omega$
		$V_{GS} = 2.5\ V$ ; $I_D = 3.2\ A$ ; $T_j = 25\ ^\circ C$	-	53	70	m $\Omega$
		$V_{GS} = 1.8\ V$ ; $I_D = 0.8\ A$ ; $T_j = 25\ ^\circ C$	-	82	123	m $\Omega$
$g_{fs}$	forward transconductance	$V_{DS} = 10\ V$ ; $I_D = 3.9\ A$ ; $T_j = 25\ ^\circ C$	-	11	-	S
<b>Dynamic characteristics (per transistor)</b>						
$Q_{G(tot)}$	total gate charge	$V_{DS} = 10\ V$ ; $I_D = 3.9\ A$ ; $V_{GS} = 4.5\ V$ ; $T_j = 25\ ^\circ C$	-	2	3.5	nC
$Q_{GS}$	gate-source charge		-	0.4	-	nC
$Q_{GD}$	gate-drain charge		-	0.6	-	nC
$C_{iss}$	input capacitance	$V_{DS} = 10\ V$ ; $f = 1\ MHz$ ; $V_{GS} = 0\ V$ ; $T_j = 25\ ^\circ C$	-	185	-	pF
$C_{oss}$	output capacitance		-	55	-	pF
$C_{rss}$	reverse transfer capacitance		-	25	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 10\ V$ ; $I_D = 3.9\ A$ ; $V_{GS} = 4.5\ V$ ; $R_{G(ext)} = 6\ \Omega$ ; $T_j = 25\ ^\circ C$	-	6	-	ns
$t_r$	rise time		-	30	-	ns
$t_{d(off)}$	turn-off delay time		-	20	-	ns
$t_f$	fall time		-	15	-	ns
<b>Source-drain diode (per transistor)</b>						
$V_{SD}$	source-drain voltage	$I_S = 1.2\ A$ ; $V_{GS} = 0\ V$ ; $T_j = 25\ ^\circ C$	-	0.8	1.2	V



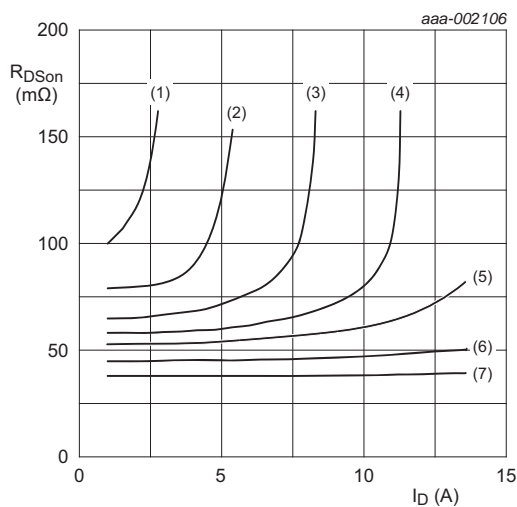
- $T_j = 25\text{ }^{\circ}\text{C}$
- (1)  $V_{GS} = 4.5\text{ V}$
  - (2)  $V_{GS} = 3.0\text{ V}$
  - (3)  $V_{GS} = 2.4\text{ V}$
  - (4)  $V_{GS} = 2.2\text{ V}$
  - (5)  $V_{GS} = 2.0\text{ V}$
  - (6)  $V_{GS} = 1.8\text{ V}$
  - (7)  $V_{GS} = 1.6\text{ V}$
  - (8)  $V_{GS} = 1.4\text{ V}$

Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



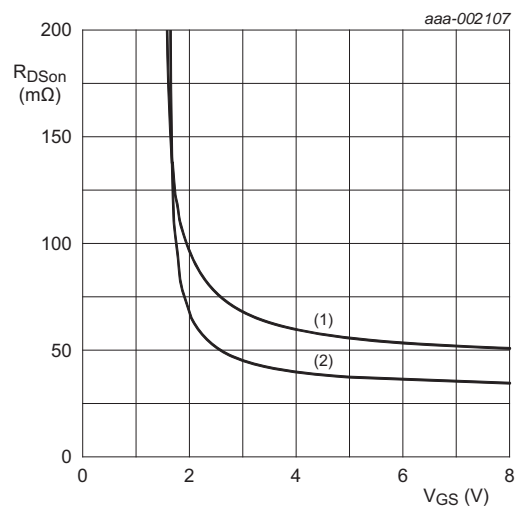
- $T_j = 25\text{ }^{\circ}\text{C}; V_{DS} = 15\text{ V}$
- (1) minimum values
  - (2) typical values
  - (3) maximum values

Fig 7. Subthreshold drain current as a function of gate-source voltage



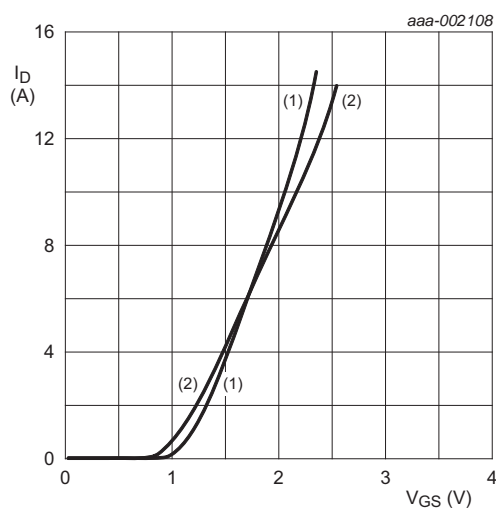
$T_j = 25\text{ }^{\circ}\text{C}$   
(1)  $V_{GS} = 1.6\text{ V}$   
(2)  $V_{GS} = 1.8\text{ V}$   
(3)  $V_{GS} = 2.0\text{ V}$   
(4)  $V_{GS} = 2.2\text{ V}$   
(5)  $V_{GS} = 2.4\text{ V}$   
(6)  $V_{GS} = 3.0\text{ V}$   
(7)  $V_{GS} = 4.5\text{ V}$

Fig 8. Drain-source on-state resistance as a function of drain current; typical values



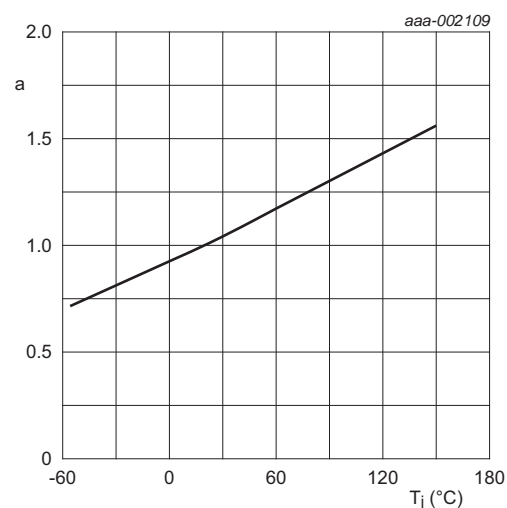
$I_D = 3.4\text{ A}$   
(1)  $T_j = 150\text{ }^{\circ}\text{C}$   
(2)  $T_j = 25\text{ }^{\circ}\text{C}$

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values



$V_{DS} > I_D \times R_{DS(on)}$   
(1)  $T_j = 25\text{ }^{\circ}\text{C}$   
(2)  $T_j = 150\text{ }^{\circ}\text{C}$

Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values



$$a = \frac{R_{DS(on)}}{R_{DS(on)(25^{\circ}\text{C})}}$$

Fig 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values



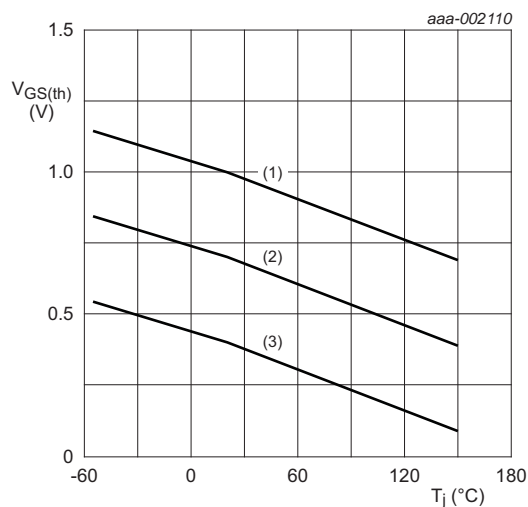


Fig 12. Gate-source threshold voltage as a function of junction temperature

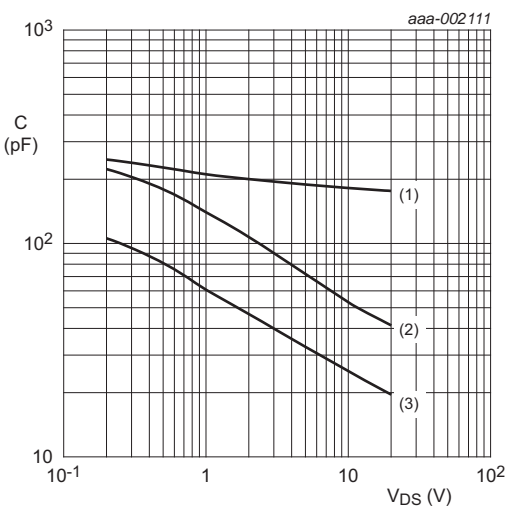


Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

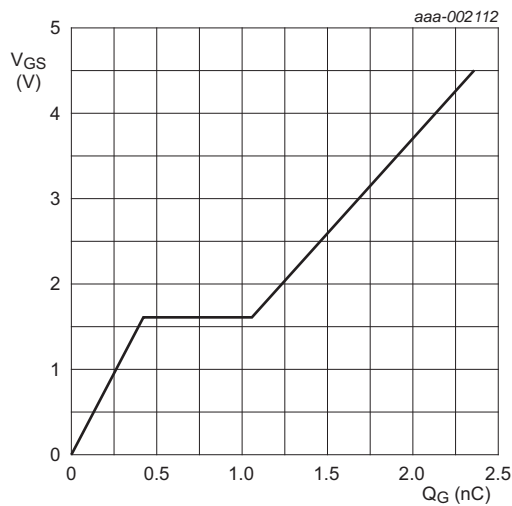


Fig 14. Gate-source voltage as a function of gate charge; typical values

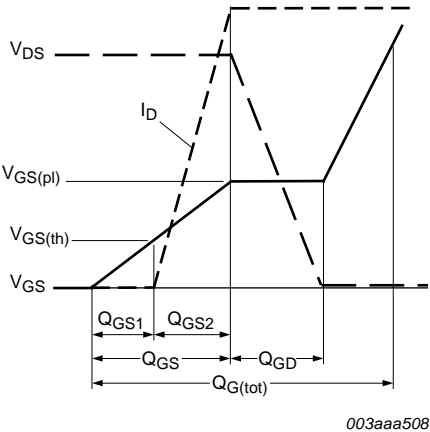
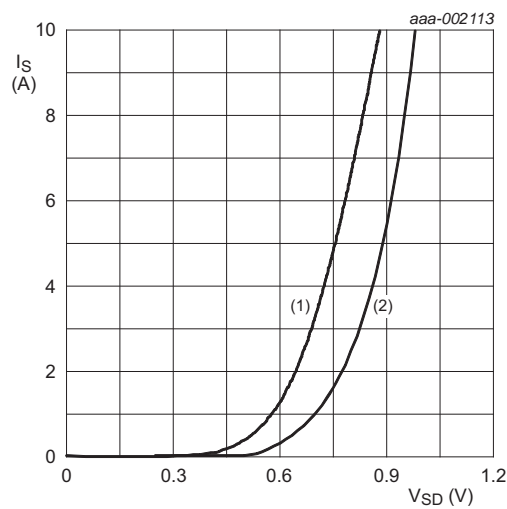


Fig 15. Gate charge waveform definitions



V<sub>GS</sub> = 0 V  
(1) T<sub>j</sub> = 150 °C  
(2) T<sub>j</sub> = 25 °C

Fig 16. Source current as a function of source-drain voltage; typical values

8. Test information

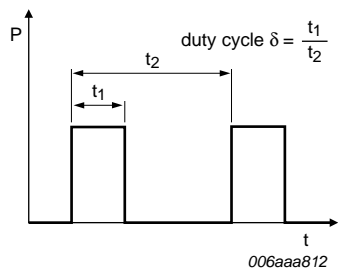


Fig 17. Duty cycle definition



## 11. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMDPB42UN v.1	20120516	Product data sheet	-	-

## 12. Legal information

### 12.1 Data sheet status

Document status <sup>[1] [2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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